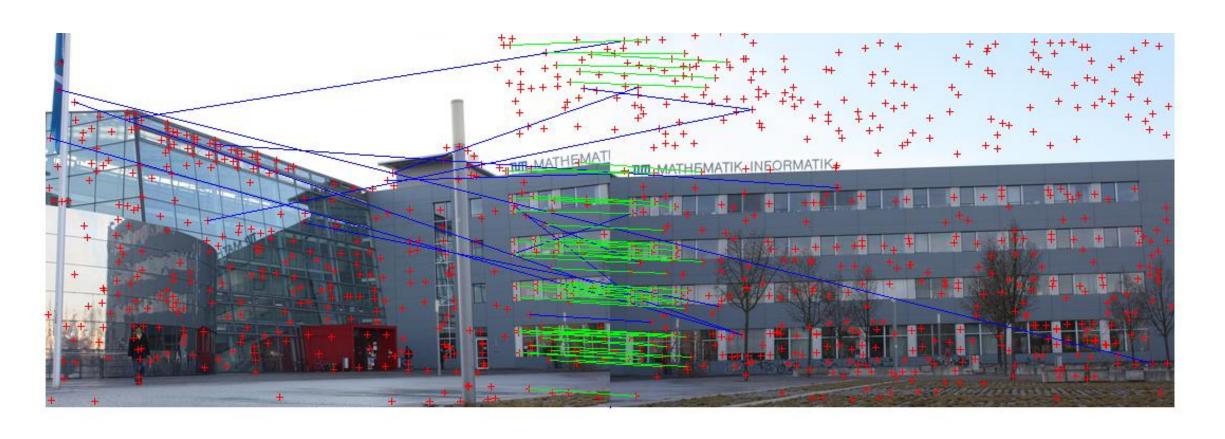
## **Features**



Yoni Chechik

www.AlisMath.com

### References

- http://szeliski.org/Book/
- http://www.cs.cornell.edu/courses/cs5670/2019sp/lectures/lectures.html
- http://www.cs.cmu.edu/~16385/
- https://towardsdatascience.com/sift-scale-invariant-feature-transformc7233dc60f37
- SIFT article: <a href="https://people.eecs.berkeley.edu/~malik/cs294/lowe-ijcv04.pdf">https://people.eecs.berkeley.edu/~malik/cs294/lowe-ijcv04.pdf</a>

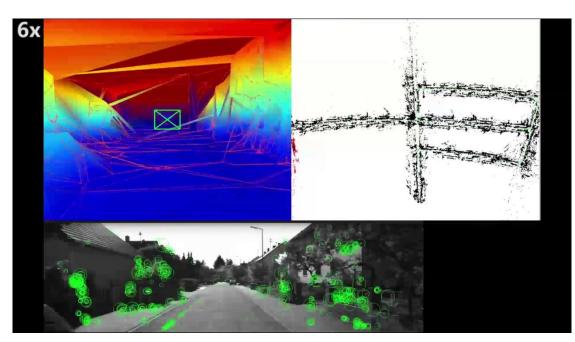
#### contents

- What and why we need features detection?
- Feature detection
  - Blob detection
  - Harris corner detection
  - SIFT detector
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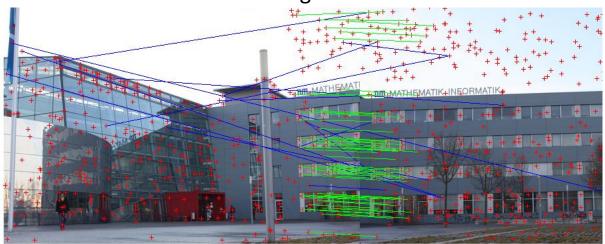
### What is a feature?

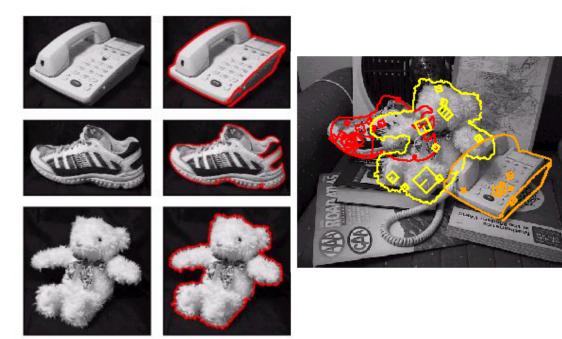
- There is no universal or exact definition of what constitutes a feature, and the exact definition often depends on the problem or the type of application. Given that, a feature is defined as an "interesting" part of an image.
  - [from: Wikipedia]

### What can we do with features?

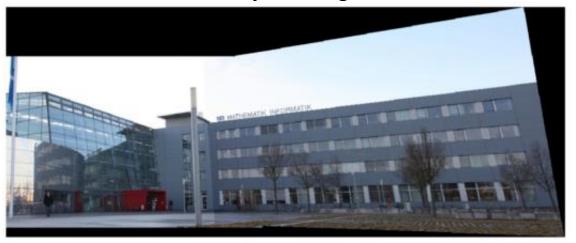


Robot navigation





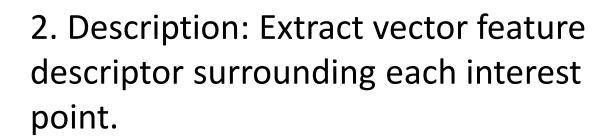
Object recognition



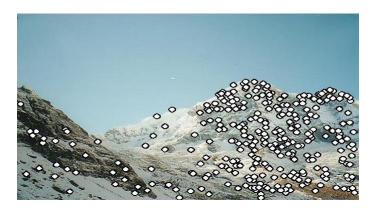
Panorama stitching

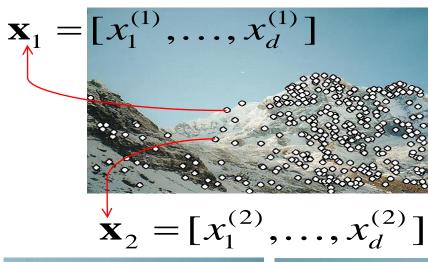
# Local features: main components

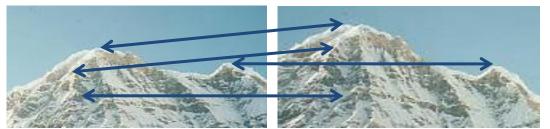
1. Detection: Identify the interest points (also called **keypoints**).



3. Matching: Determine correspondence between descriptors in two views.







### **Properties of SIFT**

- SIFT: scale invariant feature transform.
- Extraordinarily robust matching technique for local keypoint detection description and matching.
- Can handle changes in viewpoint: 3D change of POV, scale, rotation and translation.
  - Up to about 60 degree out of plane rotation.
- Can handle significant changes in illumination.
  - Sometimes even day vs. night.
- Fast and efficient—can run in real time.

# **SIFT** example





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## keypoints

- Keypoints should be a unique point of the image where all close neighbors are very different from.
- First attempt: lets take a blob in the image which has a very different surrounding, and this will be our keypoint.

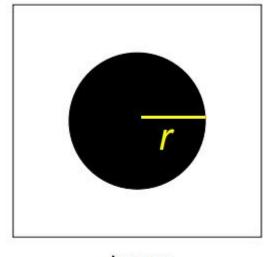


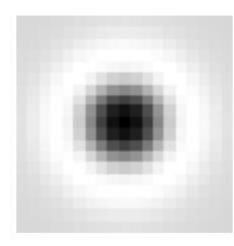
#### contents

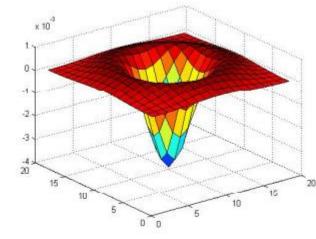
- What and why we need features detection?
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• Essentially cross correlation- we are convolving a signal with a template of a LoG (Laplacian of Gaussian) to get the highest response when the template matches the signal.

$$\operatorname{LoG}(x, y; \sigma) = \Delta_{(x,y)}G(x, y; \sigma) = \frac{\partial^2 G(x, y; \sigma)}{\partial x^2} + \frac{\partial^2 G(x, y; \sigma)}{\partial y^2} = \frac{1}{\pi \sigma^4} \left( \frac{x^2 + y^2}{2\sigma^2} - 1 \right) e^{-\frac{x^2 + y^2}{2\sigma^2}}$$

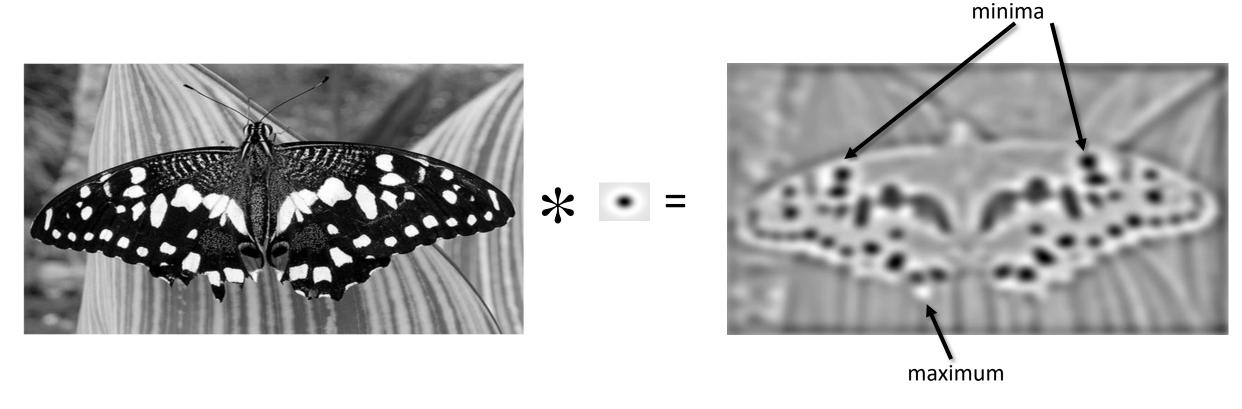






image

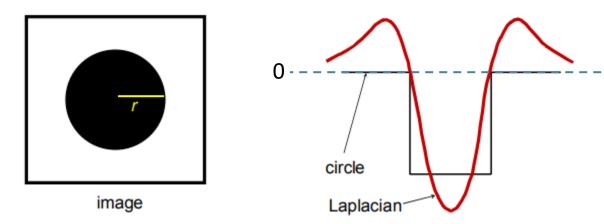
Laplacian

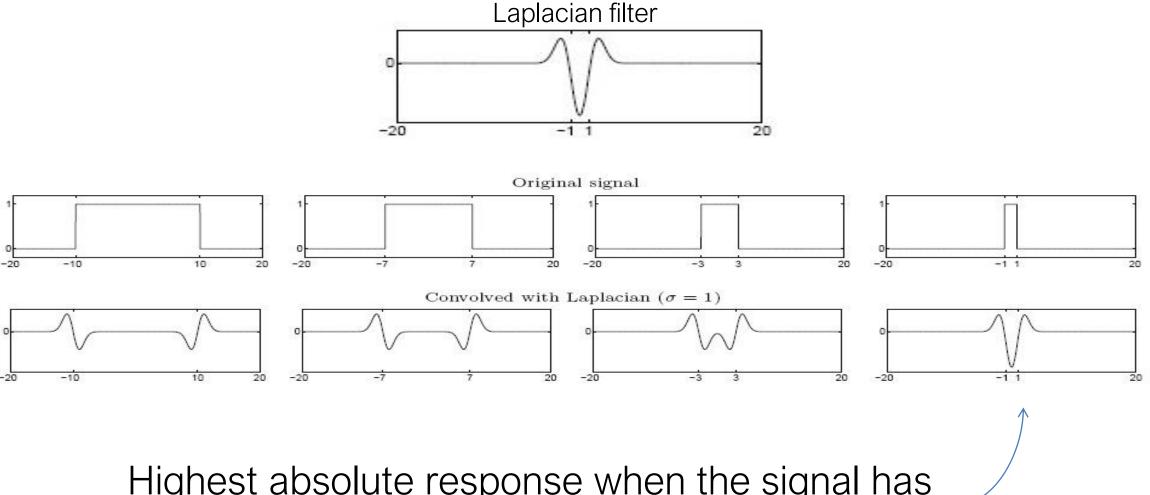


• Find maxima and minima of LoG operator in space and scale

$$\operatorname{LoG}(x, y; \sigma) = \Delta_{(x,y)}G(x, y; \sigma) = \frac{\partial^2 G(x, y; \sigma)}{\partial x^2} + \frac{\partial^2 G(x, y; \sigma)}{\partial y^2} = \frac{1}{\pi \sigma^4} \left( \frac{x^2 + y^2}{2\sigma^2} - 1 \right) e^{-\frac{x^2 + y^2}{2\sigma^2}}$$

• Highest response occurs when the signal is exactly the width of the negative part of the LoG => search for all  $\{(x,y)\}_i$  where the LoG is exactly zero (the boarder between negative and positive => the result is a circle:  $\sqrt{x^2+y^2}=r=\sqrt{2}\sigma$ .



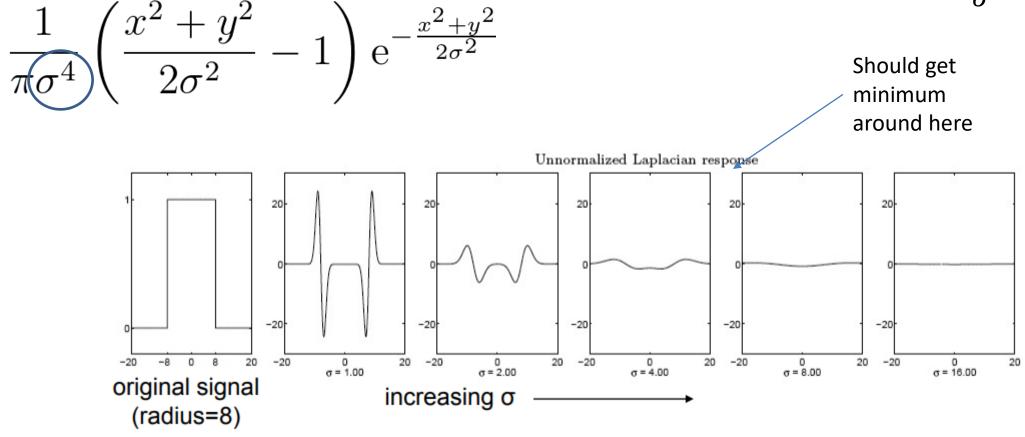


Highest absolute response when the signal has the same **characteristic scale** as the filter

- Naïve thought: let's simply run LoG filter with different  $\sigma$ 's to get all different blob scales.
  - Not really... Normalized LoG for the rescue!



- We want to find the characteristic scale of the blob by convolving it with LoGs at several scales and looking for the maximum response.
- However, LoG response decays as scale increases because of the  $\frac{1}{\sigma^4}$ :

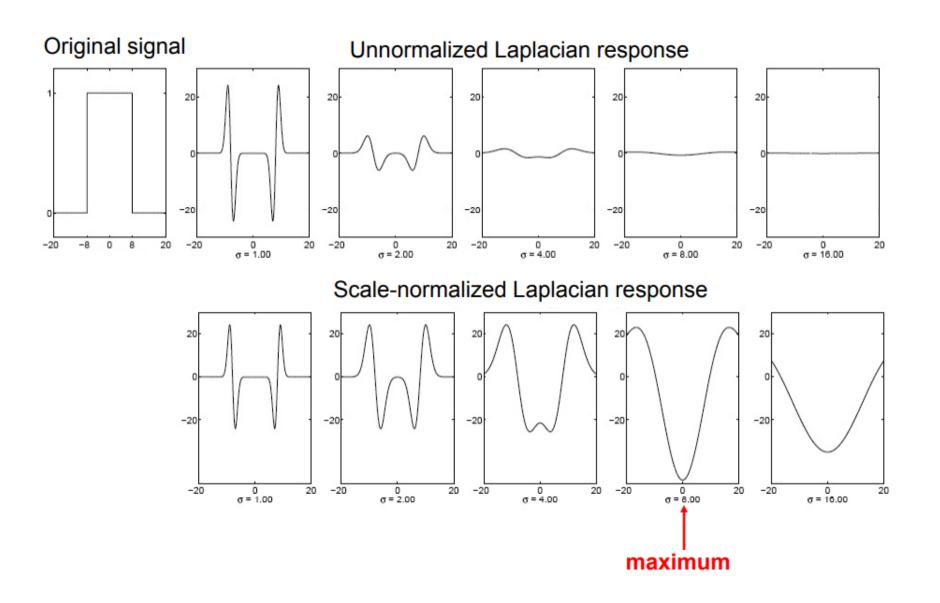


 We want that the maximum of the LoG will be always at the same value, so we are using the scale normalized LoG:

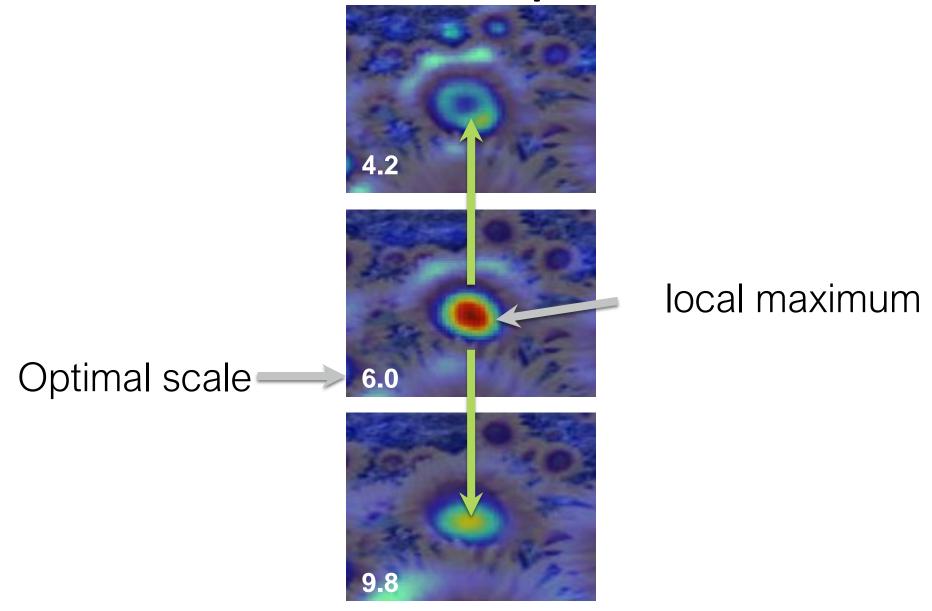
$$\operatorname{normLoG}(x, y; \sigma) = \sigma^2 \Delta_{(x,y)} G(x, y; \sigma) = \sigma^2 \left( \frac{\partial^2 G(x, y; \sigma)}{\partial x^2} + \frac{\partial^2 G(x, y; \sigma)}{\partial y^2} \right)$$

Full derivation is available here:

http://www.cim.mcgill.ca/~langer/558/2009/lecture11.pdf

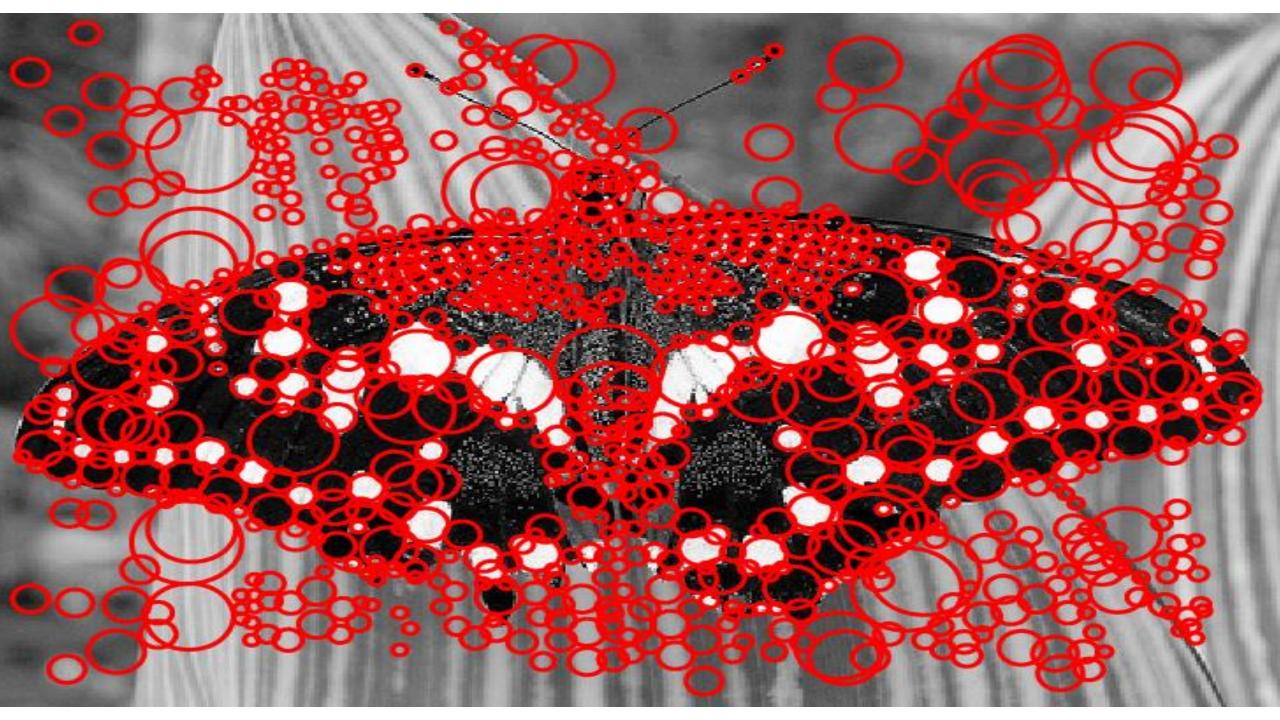


## Normalized LoG – optimal scale



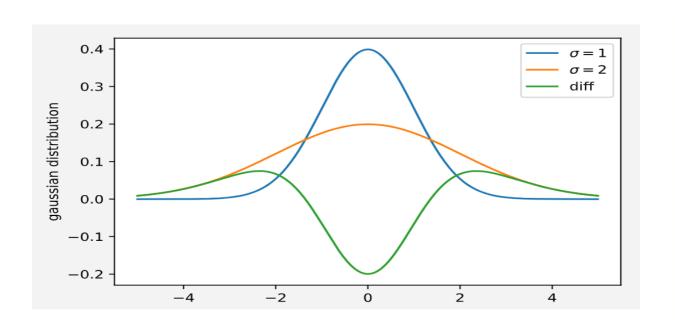
• An example of max responses:

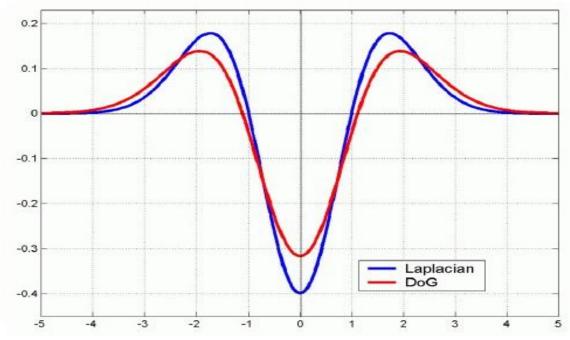




### As seen in class- edges: DoG

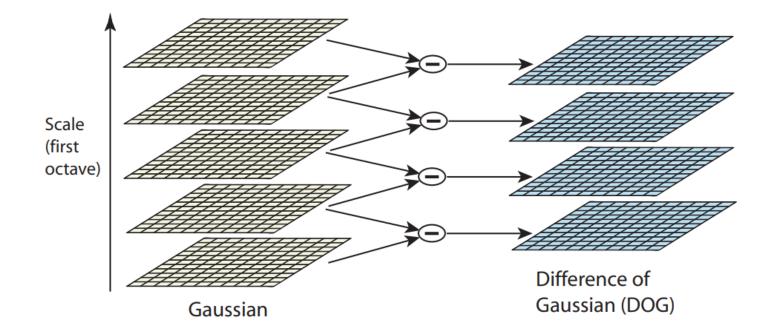
- Can also use difference of Gaussians (DoG) to mimic LoG.
- Why do we want to do this? Faster computationally (explained here: <a href="https://dsp.stackexchange.com/a/37675">https://dsp.stackexchange.com/a/37675</a>)

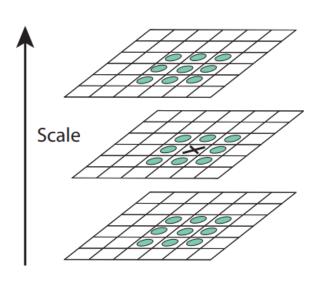




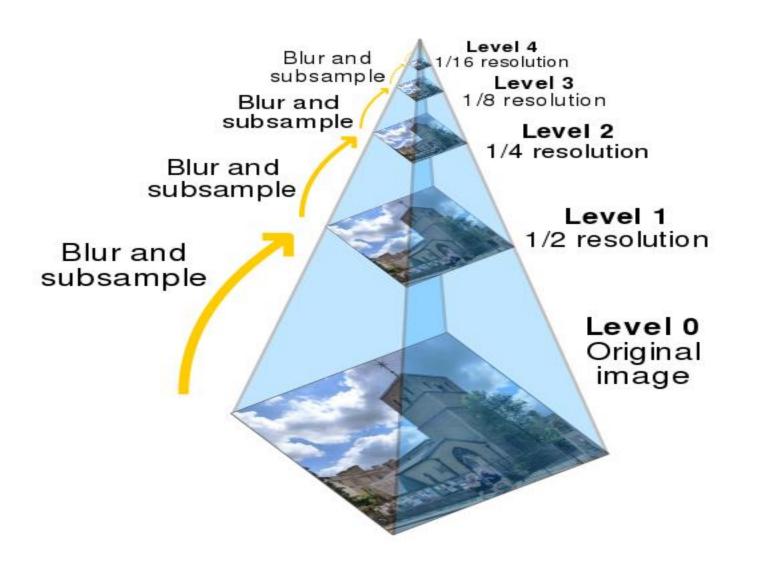
## **Blob detection algorithm**

- Build DoG images.
- Search across different image scales for the optimal scale.





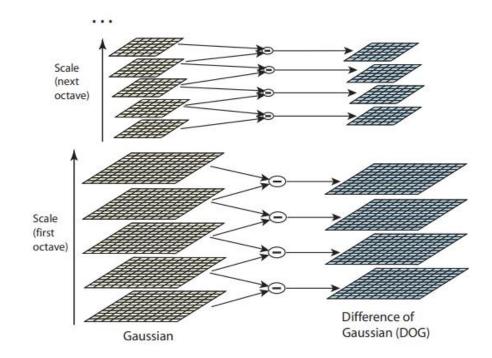
### Reminder: Gaussian pyramid





### Multi-octave LoG blob detector

- Since the images is low-passed filter so much, we can decimate the image and not loose data in the process, which makes the blob search faster!
- We can build a Gaussian pyramid (as taught in image processing recap class) and run the entire algorithm on the different octave scales.



## **Blob detection: summary**

#### Advantages:

- Invariant to translation, rotation, scale and intensity shift  $I \to I + b$  (because we use only the derivatives:  $(\nabla G) * I = \nabla (G * I) = G * (\nabla I)$ ).
- Saves a corresponding scale of the feature.

#### Disadvantages:

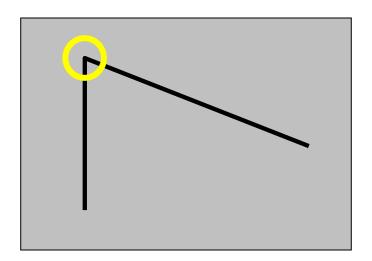
Can also match edges, not just corners.

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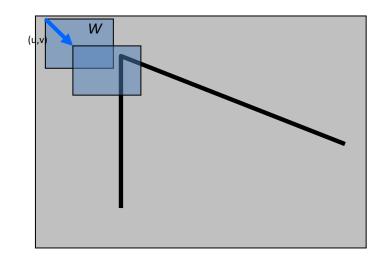
## keypoints

- Keypoints should be a unique point of the image where all close neighbors are very different from.
- Attempt 2: lets find corners in edge image- they are unique because their surrounding are very different.

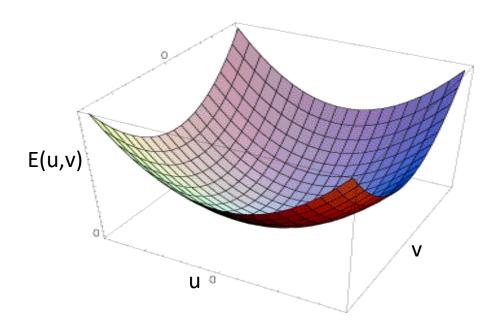


- Consider shifting the window W by (u,v)
  - compare each pixel before and after by summing up the squared differences (SSD).
  - this defines an SSD "error" E(u, v):

$$E(u,v) = \sum_{(x,y)\in W} [I(x+u,y+v) - I(x,y)]^2$$

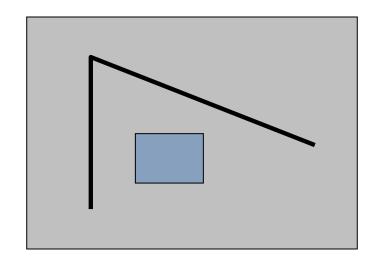


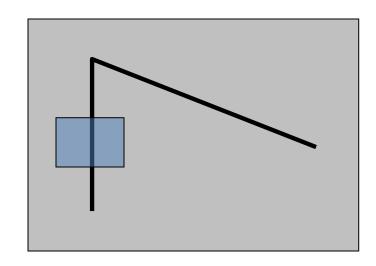
• We are happy if this error is high for all  $(u, v) \neq (0, 0)$ 

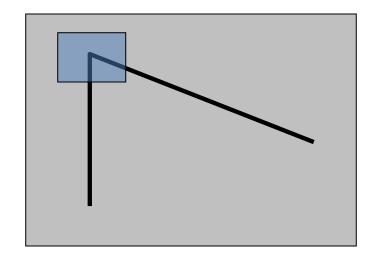


### Local measures of uniqueness

- Suppose we only consider a small window of pixels.
- How does the window change when you shift it?

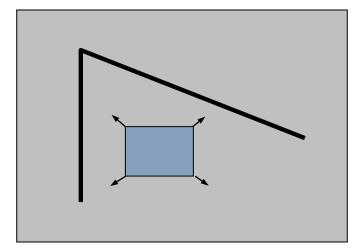




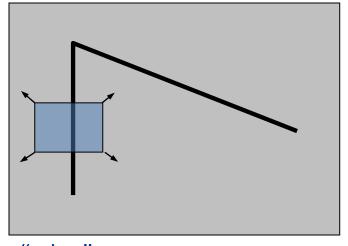


### Local measures of uniqueness

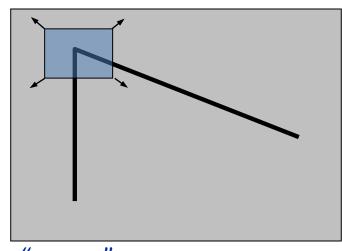
- Suppose we only consider a small window of pixels.
- How does the window change when you shift it?



"flat" region: no change in all directions



"edge": no change along the edge direction



"corner": significant change in all directions

Taylor Series expansion of *I*:

$$I(x+u,y+v) = I(x,y) + \frac{\partial I}{\partial x}u + \frac{\partial I}{\partial y}v + \text{higher order terms}$$

• If the motion (u, v) is small, then first order approximation is good

$$I(x+u,y+v) \approx I(x,y) + \frac{\partial I}{\partial x}u + \frac{\partial I}{\partial y}v$$

Plug it into the SSD error term:

$$E(u, v) = \sum_{(x,y)\in W} [I(x+u, y+v) - I(x,y)]^{2}$$

$$\approx \sum_{(x,y)\in W} [I(x,y) + I_{x}u + I_{y}v - I(x,y)]^{2}$$

$$\approx \sum_{(x,y)\in W} [I_{x}u + I_{y}v]^{2}$$

$$E(u,v) \approx \sum_{(x,y)\in W} [I_x u + I_y v]^2 \qquad A = \sum_{(x,y)\in W} I_x^2$$

$$\approx Au^2 + 2Buv + Cv^2 \qquad B = \sum_{(x,y)\in W} I_x^2$$

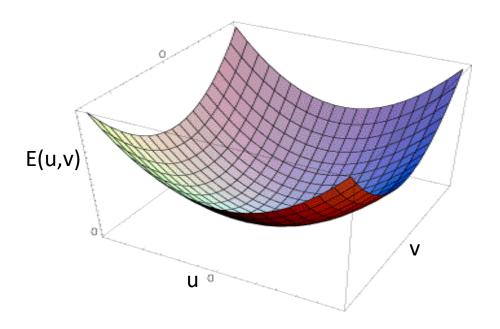
$$\approx \begin{bmatrix} u & v \end{bmatrix} \begin{bmatrix} A & B \\ B & C \end{bmatrix} \begin{bmatrix} u \\ v \end{bmatrix} \qquad C = \sum_{(x,y)\in W} I_y^2$$

Also called **second-moment matrix** or structure tensor.

$$A = \sum_{(x,y)\in W} I_x^2$$

$$B = \sum_{(x,y)\in W} I_x I_y$$

$$C = \sum_{(x,y)\in W} I_y^2$$

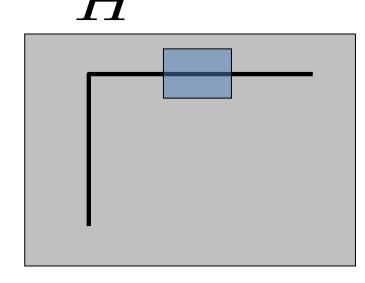


$$E(u,v) \approx \left[ \begin{array}{ccc} u & v \end{array} \right] \left[ \begin{array}{ccc} A & B \\ B & C \end{array} \right] \left[ \begin{array}{ccc} u \\ v \end{array} \right]$$

$$A = \sum_{(x,y)\in W} I_x^2$$

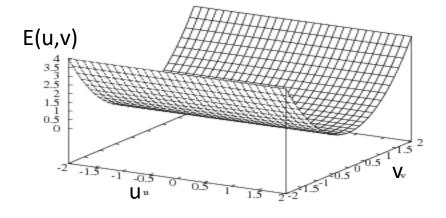
$$B = \sum_{(x,y)\in W} I_x I_y$$

$$C = \sum_{(x,y)\in W} I_y^2$$



$$I_x = 0$$

$$H = \left[ \begin{array}{cc} 0 & 0 \\ 0 & C \end{array} \right]$$

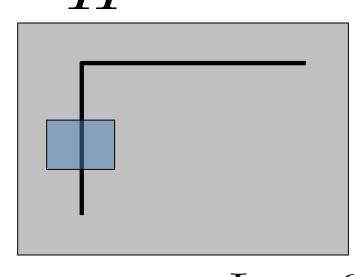


$$E(u,v) \approx \left[ \begin{array}{ccc} u & v \end{array} \right] \left[ \begin{array}{ccc} A & B \\ B & C \end{array} \right] \left[ \begin{array}{ccc} u \\ v \end{array} \right]$$

$$A = \sum_{(x,y)\in W} I_x^2$$

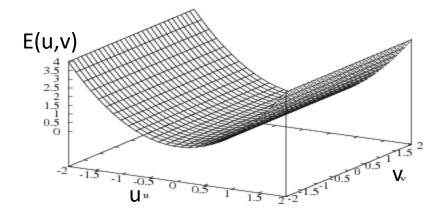
$$B = \sum_{(x,y)\in W} I_x I_y$$

$$C = \sum_{(x,y)\in W} I_y^2$$



Vertical edge: 
$$I_u=0$$

$$H = \left[ \begin{array}{cc} A & 0 \\ 0 & 0 \end{array} \right]$$



Reminder: A real symmetric matrix has an eigendecomposition of:

$$Av = \lambda v$$

$$AQ = Q\Lambda$$

$$A = Q\Lambda Q^{-1}$$

$$A \text{ is real symmetric matrix}$$

$$A = Q\Lambda Q^{T}$$

$$A = \begin{pmatrix} e_1 & e_2 \end{pmatrix} \begin{pmatrix} \lambda_1 & 0 \\ 0 & \lambda_2 \end{pmatrix} \begin{pmatrix} e_1^T \\ e_2^T \end{pmatrix}$$

Bonus: eigenvectors are orthonormal because A is real and symmetric.

• Let's look again on the error function (E=1) with H eigendecomposition:

$$x^{T}(e_{1}e_{2})\begin{pmatrix} \lambda_{1} \\ \lambda_{2} \end{pmatrix}\begin{pmatrix} e_{1}^{T} \\ e_{2}^{T} \end{pmatrix}x = 1$$

$$\lambda_{1}x^{T}e_{1}e_{1}^{T}x + \lambda_{2}x^{T}e_{2}e_{2}^{T}x = 1$$

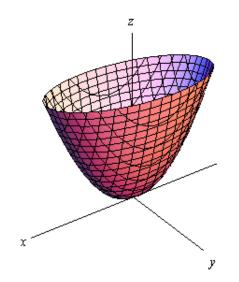
$$\frac{\left(e_{1}^{T}x\right)^{2}}{\left(\frac{1}{\sqrt{\lambda_{1}}}\right)^{2}} + \frac{\left(e_{2}^{T}x\right)^{2}}{\left(\frac{1}{\sqrt{\lambda_{2}}}\right)^{2}} = 1$$

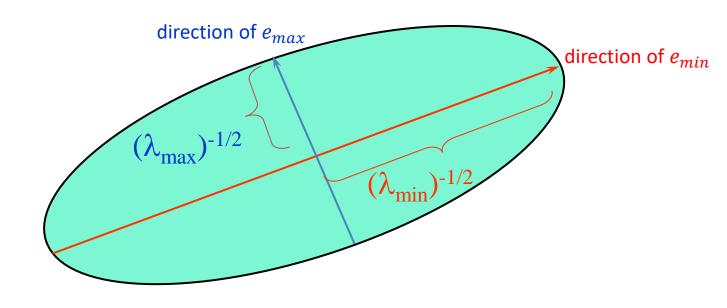
• Which is exactly as a rotated ellipse with a center of (0,0):

$$\frac{(x\cos(\theta) + y\sin(\theta))^2}{a^2} + \frac{(x\sin(\theta) - y\cos(\theta))^2}{b^2} = 1$$

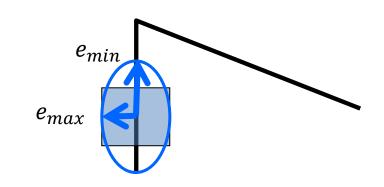
Our error can be represented as an ellipsoid

$$\frac{\left(e_1^T x\right)^2}{\left(\frac{1}{\sqrt{\lambda_1}}\right)^2} + \frac{\left(e_2^T x\right)^2}{\left(\frac{1}{\sqrt{\lambda_2}}\right)^2} = E(x)$$

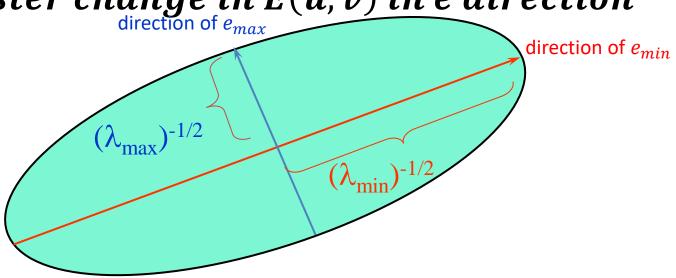




- Eigenvalues and eigenvectors of H
  - $e_1$  = direction of largest increase in E
  - $\lambda_1$  = relative increase in direction  $e_1$
  - $e_2$  = direction of smallest increase in E
  - $\lambda_2$  = relative increase in direction  $e_2$



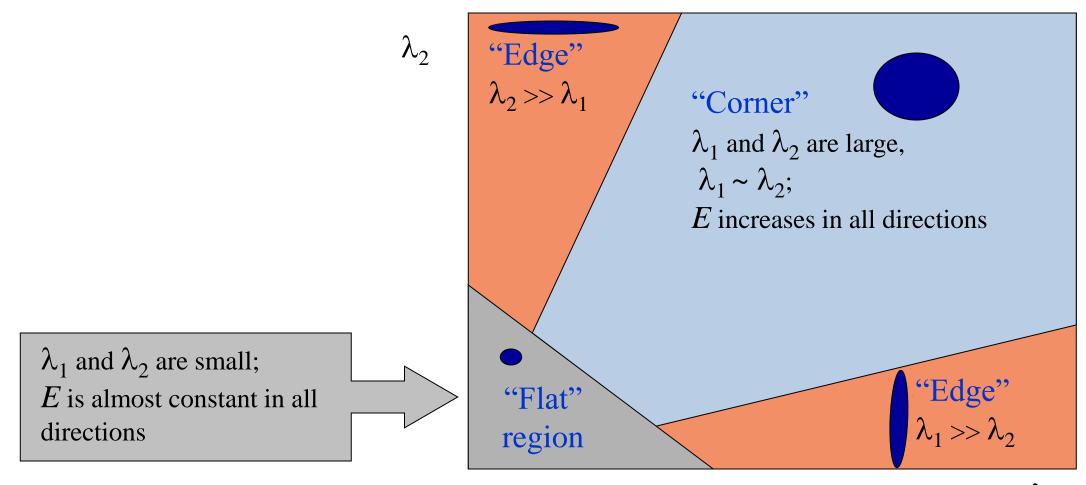
•  $\lambda$  larger  $\leftrightarrow \lambda^{-\frac{1}{2}}$  smaller  $\leftrightarrow$  faster change in E(u,v) in e direction direction of  $e_{max}$ 



## Interpreting the eigenvalues

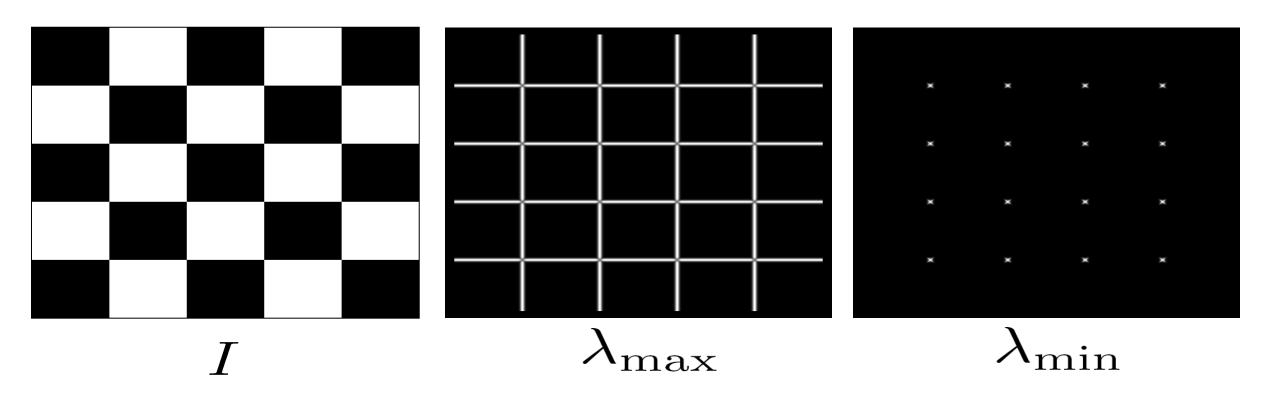
- A "good" corner will have a large  $R=\lambda_{min}$ , which means big change of E in both axis.
- Getting the eigenvectors and eigenvalues is computationally inefficient.
- Instead, use two tricks:
  - $\prod_i \lambda_i = \det(A)$
  - $\sum_{i} \lambda_{i} = trace(A)$
- Then we can more easily compute  $R \approx \lambda_{min}$ :
  - $R = \det(A) \kappa * trace(A)^2 \quad (\kappa \in [0.04, 0.06])$
  - $R = \frac{\det(A)}{trace(A)} = \frac{\lambda_1 \lambda_2}{\lambda_1 + \lambda_2}$

### Interpreting the eigenvalues



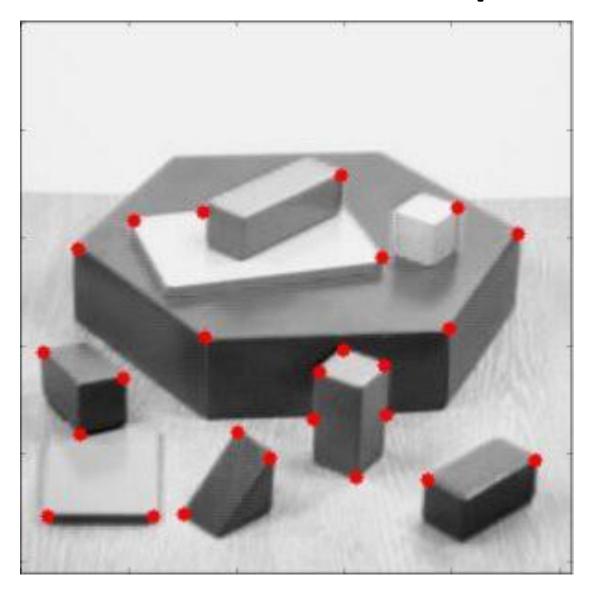
## Interpreting the eigenvalues

• A binary threshold of pixels above  $\lambda_{max}$  and  $\lambda_{min}$ 



- Compute gradients of patch around each pixel.
- Compute the second-moment matrix.
- Compute eigendecomposition of covariance matrix.
- Use eigenvalues to find corners.

# Harris detector example



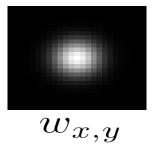
# Weighting the derivatives

In practice, using a simple window W doesn't work too well

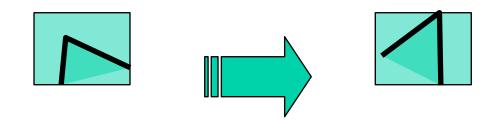
$$H = \sum_{(x,y)\in W} \begin{bmatrix} I_x^2 & I_x I_y \\ I_x I_y & I_y^2 \end{bmatrix}$$

 Instead, we'll weight each derivative value based on its distance from the center pixel

$$H = \sum_{(x,y)\in W} w_{x,y} \begin{bmatrix} I_x^2 & I_x I_y \\ I_x I_y & I_y^2 \end{bmatrix}$$



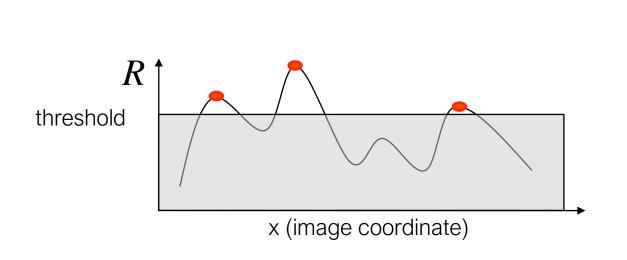
## Harris corner detector- rotation and translation

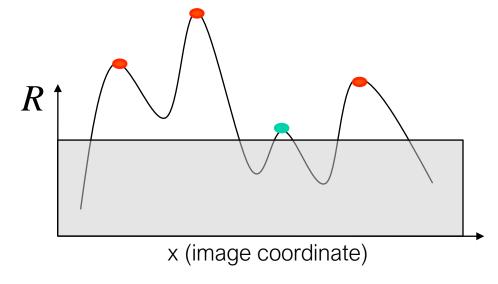


- Eigenvalues remains the same on rotation => invariant to rotation!
- The feature is also translation invariant (easy to see).

# Harris corner detector- intensity

- Partial invariance to affine intensity change
- Only derivatives are used => invariance to intensity shift  $I \rightarrow I + b$
- Not completely invariance to Intensity scale:  $I \rightarrow a \cdot I$





# The Harris corner detector is not invariant to scale



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## SIFT keypoint detection

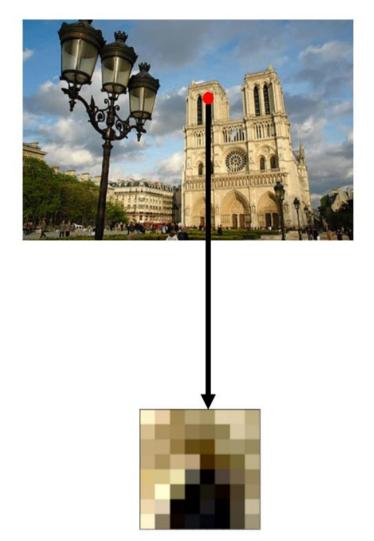
- Find blobs using the improved blob detection (across different octave scale).
- Use interpolation to find exact peak of keypoint.
  - The interpolation takes place in x, y and scale dimension.
- Eliminate edge response with Harris corner detector variant (called principal curvature) around temp keypoints in interpolated space and scale.
- SIFT has the advantages of both previous technics and is invariance to: rotation, translation, scale, illumination shift and partially to 3D change of viewpoint since it is a local keypoint detector.

#### contents

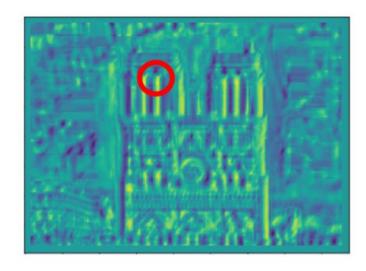
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# Template matching- SSD, ZNCC

- Good for very carefully constructed scenarios.
- Can't handle change in rotation and scale.







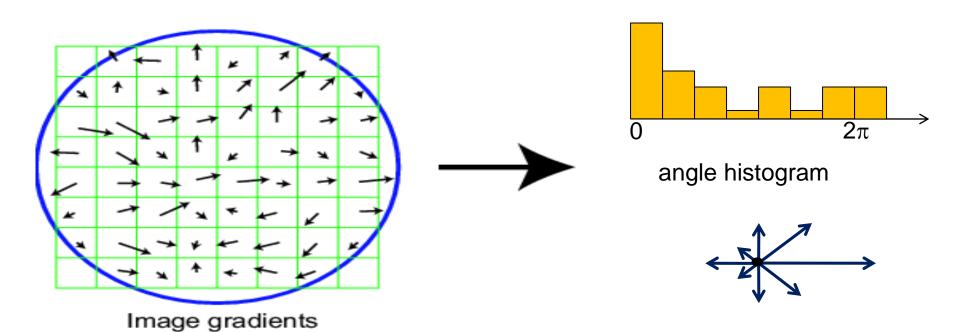
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- Feature detection
  - Blob detection
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  - SIFT detector
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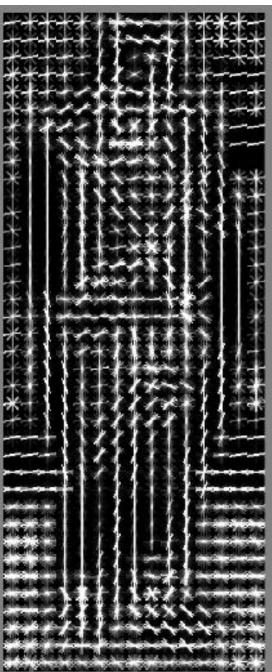
## **HOG- Histogram of Oriented Gradients**

- A dense representation of image as blocks, each with its own histogram of gradient directions, weighted by the gradient magnitude.
- Originally used to detect humans in images.
- Equations for gradient magnitude and orientation:

$$m(x,y) = \sqrt{(L(x+1,y) - L(x-1,y))^2 + (L(x,y+1) - L(x,y-1))^2}$$
  
$$\theta(x,y) = \tan^{-1}((L(x,y+1) - L(x,y-1))/(L(x+1,y) - L(x-1,y)))$$





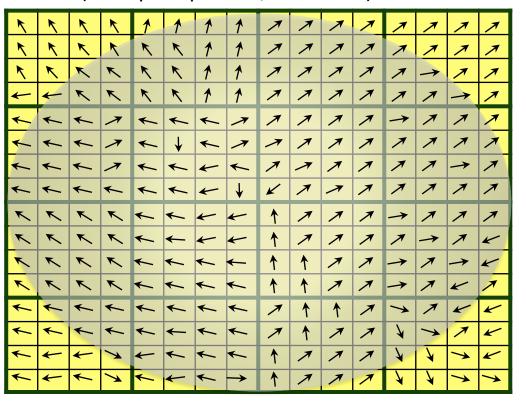


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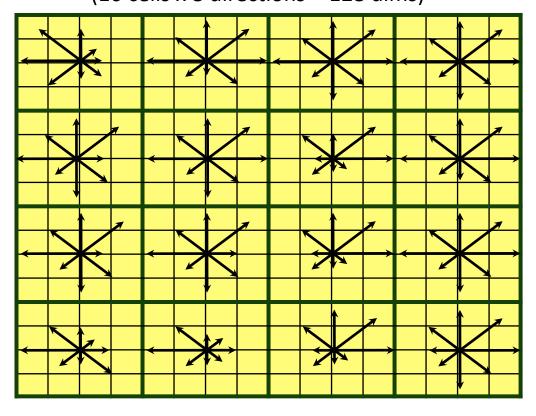
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- •First, find the main patch direction using a HOG on all gradients around keypoint at the selected scale, all further calculation is done around this direction (this is how to get a rotation invariance descriptor).
- Take 16x16 patch around detected feature and calculate gradient orientation and magnitude to each pixel.
- Magnitude is also weighted by a Gaussian around the keypoint.
- •Build sub-blocks of 4X4 of the patch.
- •Create 8-bin histogram of edge orientations (weighted by Gaussian and magnitude of gradient) to each sub-block.
- •Take the 4X4X8=128 results of histograms and concatenate them to a single feature vector. Normalize this vector to be invariance to illumination scale.

Image Gradients (4 x 4 pixel per cell, 4 x 4 cells)

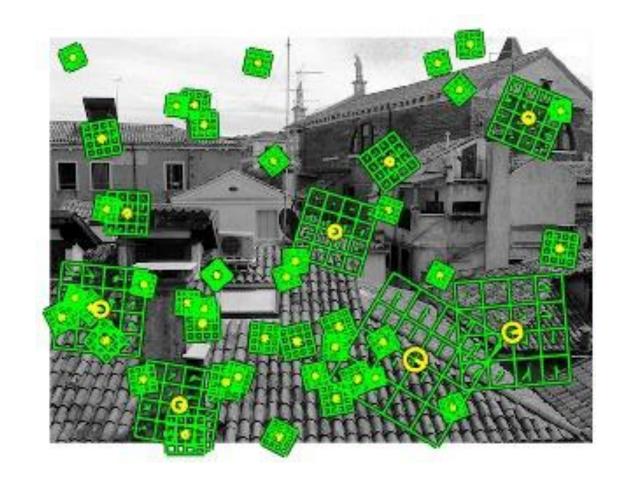


SIFT descriptor (16 cells x 8 directions = 128 dims)



Gaussian weighting





#### Invariant to:

- Rotation (due to shifting of the histograms around the main direction).
- Translation (easy to see).
- Scale (build at a specific scale).
- Illumination shift (only derivatives are used).
- Illumination scale (normalize the feature vector).
- 3D change of view (the descriptor is of local keypoints).

#### contents

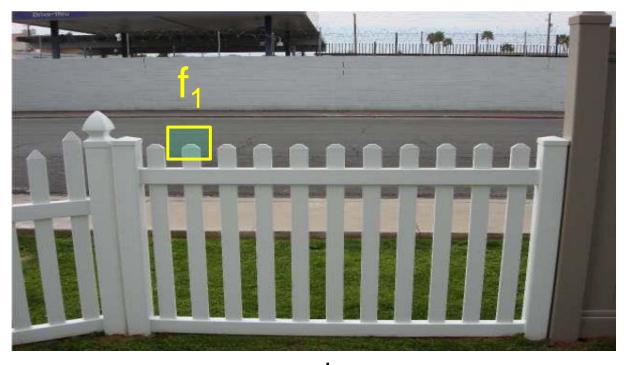
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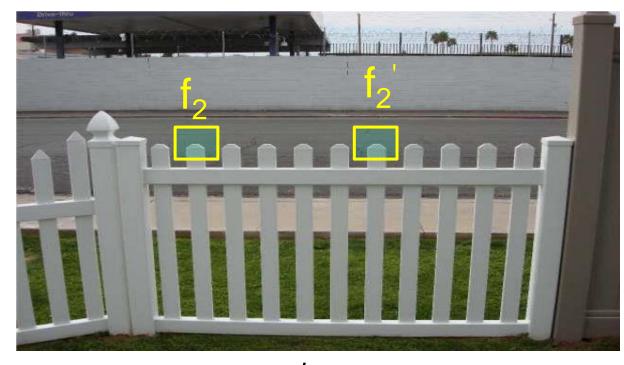
### **SIFT Feature matching**

- Given a feature in I<sub>1</sub>, how to find the best match in I<sub>2</sub>?
  - 1. Define distance function that compares two descriptors
  - 2. Test all the features in  $I_2$ , find the one with min distance
- What distance function to use?

## **SIFT Feature matching**

- What distance function to use?
  - Simple approach: L<sub>2</sub> distance, L<sub>2</sub> =  $||f_1 f_2|| = \sqrt{\sum_i (f_{1i} f_{2i})^2}$
  - Good overall but can also give small distances for ambiguous (incorrect) matches.

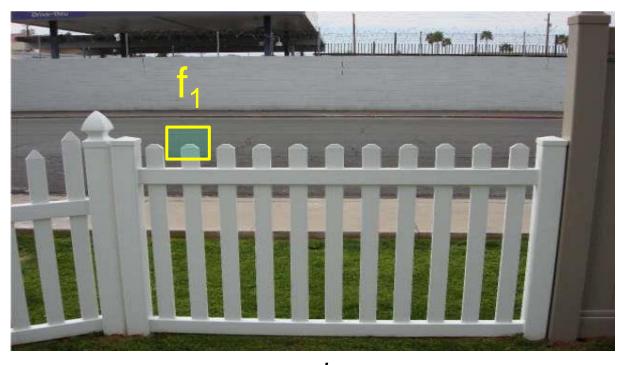


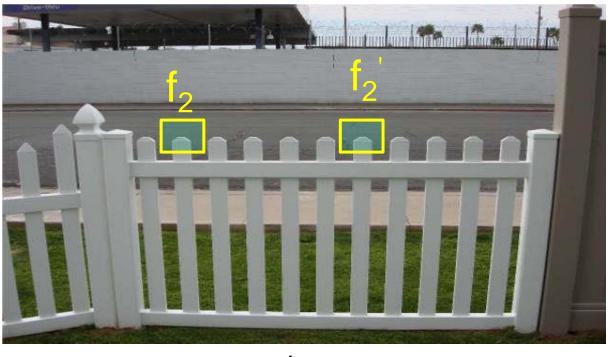


 $I_1$ 

### **SIFT Feature matching**

- Better approach: ratio distance:  $||f_1 f_2|| / ||f_1 f_2'|| < TH$ 
  - $f_2$  is best match to  $f_1$  in  $I_2$
  - $-f_2'$  is  $2^{nd}$  best match to  $f_1$  in  $I_2$
  - gives larger values for distinct matches.





1.

#### What haven't been covered about SIFT

- Computational fast search of descriptors.
- A lot of minor engineering steps (e.g. thresholding of features).
- And more... this algorithm is 28 pages long article (with 52000 citations!!!)
  - https://www.cs.ubc.ca/~lowe/papers/ijcv04.pdf

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### **Panoramas**

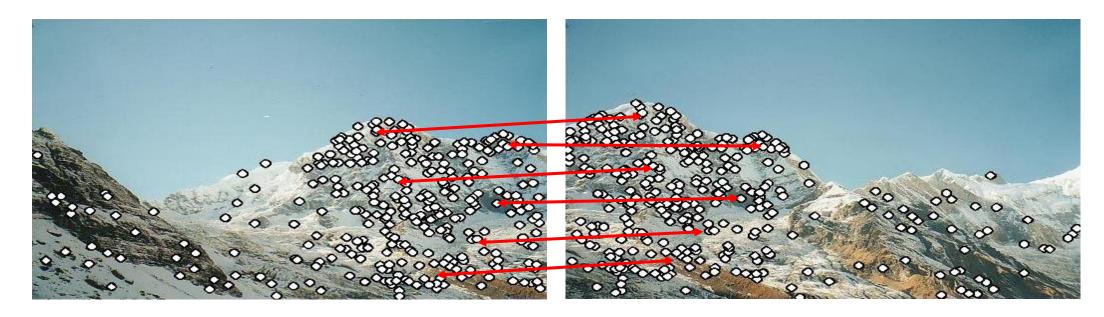
• We have two images – how do we combine them?





#### **Panoramas**

- Use SIFT to match descriptors of the two images.
- Between the two images there can be an unknown homographic transformation.
  - How do we align the two images?



#### **Panoramas**

- Find the best homographic projection from  $I_2$  to  $I_1$  using RANSAC.
  - Finding this homographic projection is the same as finding the camera calibration matrix that we've seen, only with 3X3 matrix.
  - RANSAC is used to drop wrongly matched points (outliers). Only 3 points needed to be chosen at random to find a RANSAC projection.

